

# 1D5N70K-TB

Preliminary

# 1.5A, 700V N-CHANNEL POWER MOSFET

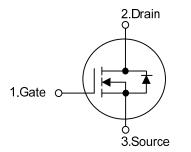
### DESCRIPTION

The UTC **1D5N70K-TB** is a high voltage MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

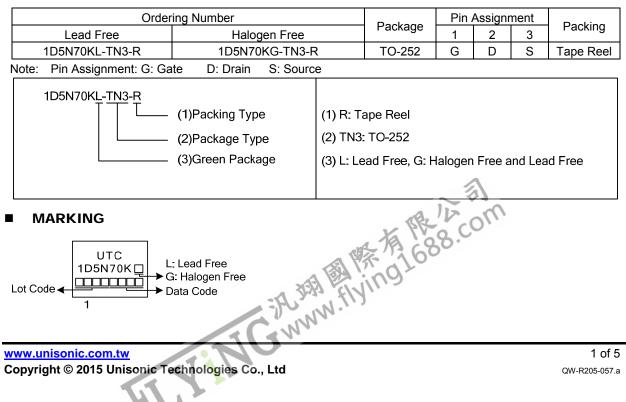
#### FEATURES

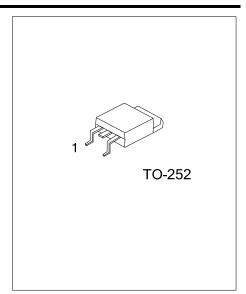
- \*  $R_{\text{DS(ON)}}$  < 10 $\Omega$  @ V\_{GS} = 10V ,  $I_{\text{D}}$  = 1.5 A
- \* Fast switching capability
- \* Avalanche energy specified
- \* Improved dv/dt capability, high ruggedness

#### SYMBOL









#### ABSOLUTE MAXIMUM RATINGS (T<sub>c</sub> = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V <sub>DSS</sub>	700	V	
Gate-Source Voltage		V <sub>GSS</sub>	±30	V	
Drain Current	Continuous	I <sub>D</sub>	1.5	Α	
	Pulsed (Note 2)	I <sub>DM</sub>	6	А	
Avalanche Energy	Single Pulsed (Note 3)	E <sub>AS</sub>	57	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns	
Power Dissipation		PD	27	W	
Junction Temperature		TJ	+150	°C	
Operating Temperature		T <sub>OPR</sub>	-55 ~ +150	°C	
Storage Temperature		T <sub>STG</sub>	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating : Pulse width limited by  $T_J$ .

3. L=45mH, I<sub>AS</sub>=1.5A, V<sub>DD</sub>=50V, R<sub>G</sub>=25  $\Omega$ , Starting T<sub>J</sub> = 25°C

4. I<sub>SD</sub> $\leq$ 1.5A, di/dt $\leq$ 200A/µs, V<sub>DD</sub> $\leq$  BV<sub>DSS</sub>, Starting T<sub>J</sub> = 25°C

#### THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	$\theta_{JA}$	θ <sub>JA</sub> 110		
Junction to Case	θ <sub>JC</sub>	4.5	°C/W	

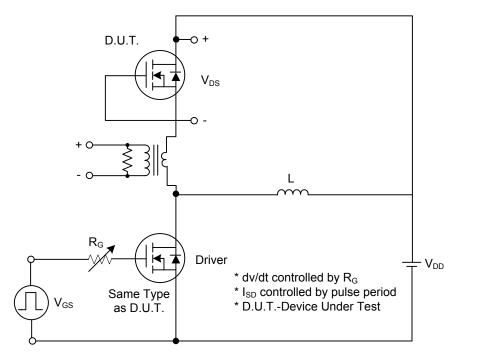
#### ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS		OTHEOL				100 0 0	
Drain-Source Breakdown Voltage		BV <sub>DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250µA	700			V
Drain-Source Leakage Current		I <sub>DSS</sub>	$V_{DS} = 700V, V_{GS} = 0V$			10	μA
<b>z</b>	Forward		$V_{GS} = 30V, V_{DS} = 0V$			100	nA
Gate-Source Leakage Current	Reverse	699	$V_{GS} = -30V, V_{DS} = 0V$			-100	nA
Breakdown Voltage Temperature Coefficient		∆BV <sub>DSS</sub> /∆TJ	$I_D$ = 250 µA, Referenced to 25°C		0.4		V/°C
ON CHARACTERISTICS							
Gate Threshold Voltage		V <sub>GS(TH)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.5		5.5	V
Static Drain-Source On-State Res	sistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> =1.5A			10	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		CISS	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, f =1MHz		270		рF
Output Capacitance		C <sub>oss</sub>			30		рF
Reverse Transfer Capacitance		C <sub>RSS</sub>			13		рF
SWITCHING CHARACTERISTIC	S						
Turn-On Delay Time		t <sub>D (ON)</sub>			45		ns
Turn-On Rise Time		t <sub>R</sub>	$V_{DD}$ =30V, $I_{D}$ =0.5A, $R_{G}$ =25 $\Omega$		23		ns
Turn-Off Delay Time		t <sub>D(OFF)</sub>	(Note 1, 2)		47		ns
Turn-Off Fall Time		t⊨			8		ns
Total Gate Charge		$Q_G$	V <sub>DS</sub> =50V, I <sub>D</sub> =1.3A, V <sub>GS</sub> =10V		17.5		nC
Gate-Source Charge		Q <sub>GS</sub>	$V_{DS}=50V, I_D=1.3A, V_{GS}=10V$	2	3.2		nC
Gate-Drain Charge		$Q_{GD}$	(Note 1, 2)		1.9		nC
DRAIN-SOURCE DIODE CHARA	ACTERIST	ICS	1 18 . 00.				
Drain-Source Diode Forward Volt	age	V <sub>SD</sub>	$V_{GS} = 0 V$ , $I_{SD} = 1.5 A$			1.4	V
Continuous Drain-Source Current		I <sub>SD</sub>				1.5	Α
Pulsed Drain-Source Current		SM	13 - E/1/13 - 61			6.0	Α
Notes: 1. Pulse Test: Pulse width	< 300us I	Duty cycle<2%	N.				

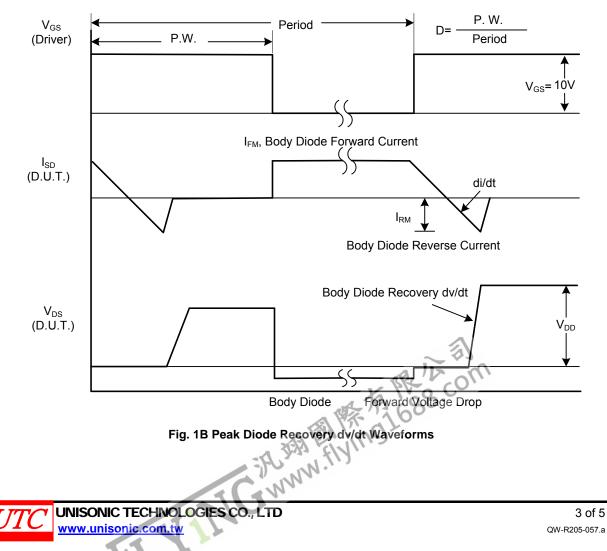
Notes: 1. Pulse Test: Pulse width  $\leq$  300µs, Duty cycle $\leq$ 2%

2. Essentially independent of operating temperature

#### TEST CIRCUITS AND WAVEFORMS



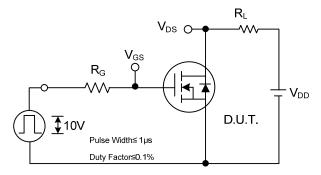




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## **TEST CIRCUITS AND WAVEFORMS (Cont.)**





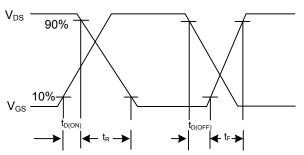


Fig. 2B Switching Waveforms

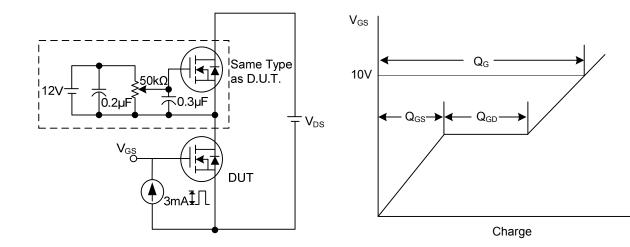
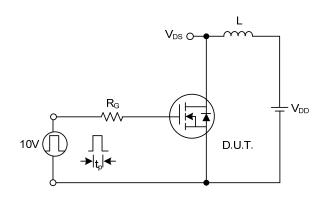
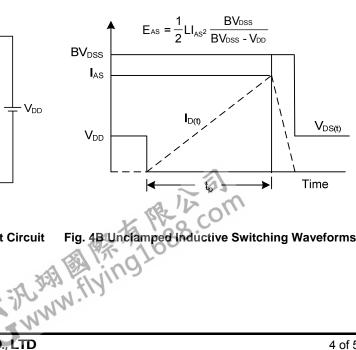


Fig. 3A Gate Charge Test Circuit











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